



Main functions S: Standard O: Optional

Image display	Enlarge/reduce, full screen, and magnifying glass	S
	Capture thumbnail	S
	Scale, annotation, and profile	S
	Grid	S
	LUT, histogram, and sequence replay	S
Image capture	3D Surface Model (Part of EDF option) *LV Series Only	O
	Auto-capture	S
	Time lapse	S
	Z series and multi-point	S
Data formats	Stitching	S
	Live compare	O
	BMP, TIFF, JPEG, and JPEG2000	S
	GIF, PNG, ICS/IDS	S
	White balance and tone	S
Image processing	LUT and shading correction	S
	Contrast and hue/saturation correction	S
	Edge enhancement, averaging, and smoothing	S
	EDF and realtime EDF *LV Series Only	O
Image editing	Crop	S
	Image overlay	4 (RGB)
	Cut, copy, paste, rotate, invert, and resize	S
	Component extraction	S
Image analysis	Pseudo-color	S
	Calibration (length)	S
	Manual measurement (count, length, area, angle, circle, and ellipse)	S
	AutoMeasure (Object Count)	O
Peripheral device control	3D measurement (EDF) *LV Series Only	O
	Microscope control	S
Screen control	3rd Party Device Control	O
	Organizer layout	S
Other	Layout manager	S
	Printing, PDF output, mail transmission	S
	Optical Configurations	S
	Report generator	S
	Macros	S
	Advanced Macros	O
Databases	O	

Compatible devices

Microscopes and accessories	Eclipse LV series
	Universal Zoom Microscope AZ100M
	C-HGFIE HG Precentered Fiber Illuminator (Motorized)
Cameras	Digital Sight series
	DXM1200 series
Accessories from other manufacturers	Stages: Prior, Marzhauser, LUDL, ASI
	*Note: For the detail, please contact your local agent or Nikon Corp.
	Prior Z-Focus Module
	EXFO XCite 120 series fiber illuminators

Operating environment

CPU	3.2GHz Intel® Pentium® IV processor or better
RAM	1GB or more
OS	Microsoft® Windows® XP SP2 (English version)
Hard disk space	600MB or more required for installation
Display	1280 x 1024 or better (TrueColor mode)

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Imaging Software
NIS Elements D
 Documentation

Specifications and equipment are subject to change without any notice or obligation on the part of the manufacturer. May 2007 ©2007 NIKON CORPORATION

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WARNING	TO ENSURE CORRECT USAGE, READ THE CORRESPONDING MANUALS CAREFULLY BEFORE USING THE EQUIPMENT.
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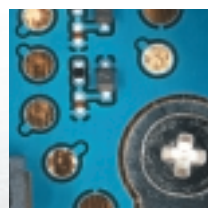
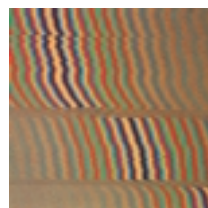
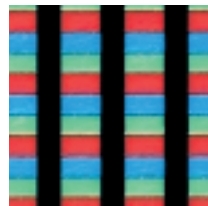
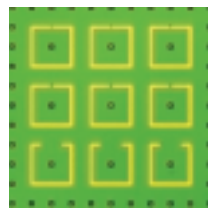
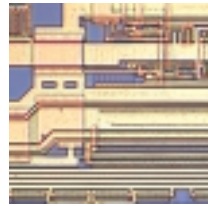
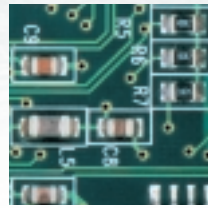


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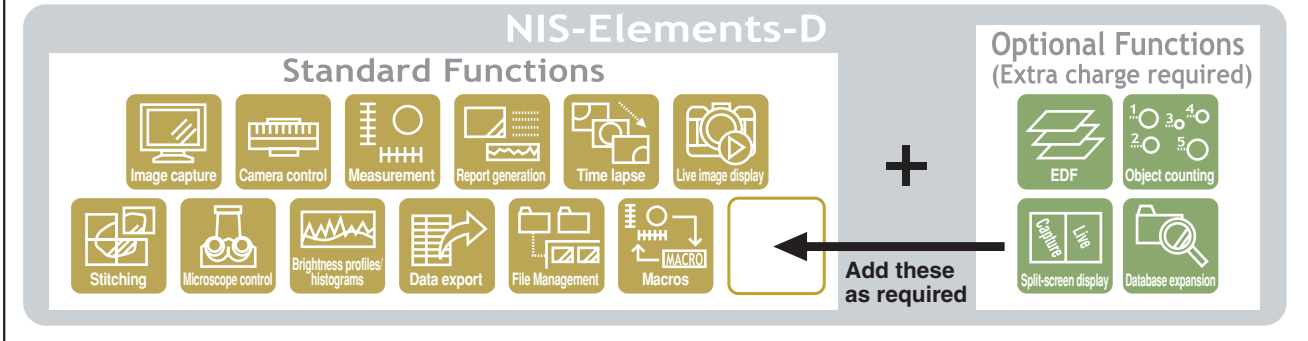
NIS-Elements D offers a total solution for capture, analysis and image file management.

Ease of use and a range of powerful functions make NIS-Elements D an excellent tool for a wide range of microscope based inspection methods and protocols.



Flexibility has been built into the design of the software's Standard Function and Optional Functions.

Standard Functions of NIS-Elements D were designed to facilitate efficient microscopic inspection in industrial production and quality control. Standard Functions include image capture, measurement, data export, file management and report generation.



Automated Microscope control provide a streamlined workflow Standard Functions

Integration of automated microscope control of motorized components such as illumination, Z position and nosepiece rotation allow for easy image capture and sample inspection.

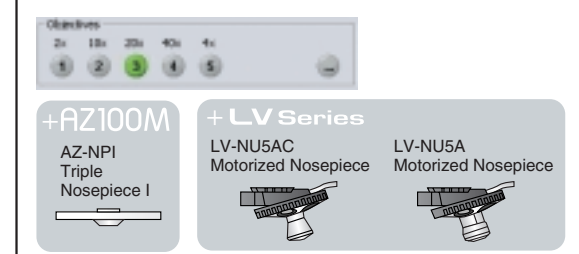


Microscope control window (LV-PAD)

Powerful Nosepiece Control

Switch Magnifications and Configurations

Calibration and Scales are linked automatically with objectives. Changing magnifications is seamlessly linked to the appropriate spatial calibration. These setting can also be tied to camera parameters to ensure the correct measurements are applied to the captured images.

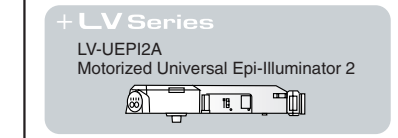
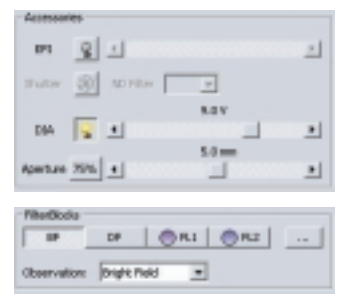


*The AZ-NPI Intelligent Triple (manual) nosepiece transmits objective magnification information to PC or CCU via the AZ-MC controller.

Control of illumination

Recording and replay of illumination conditions

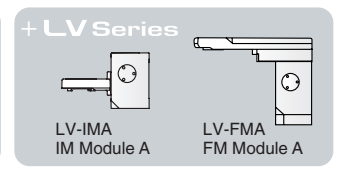
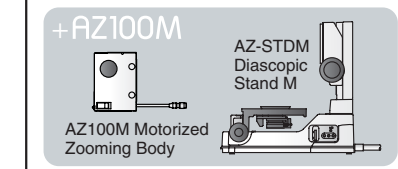
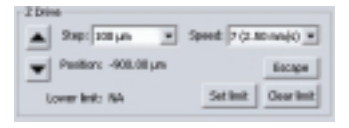
Stored illumination settings, which integrate shutter control, lamp voltage, illumination method (brightfield, darkfield, fluorescence) are easily applied to image capture. Specific configurations can be saved and recalled at later times or with different operators to help provide consistent image capture.



Control of Z positioning

Motorized focus control

Automated control of the Z motor and positioning is the core of 3D image capture and autofocus. Linked with the EDF (extended depth of focus) module (optional- see P6), composite images that have been captured in a different Z-axis can be combined to create an all-in-focus image.



NIS-Elements D is the complete toolkit for image capture, measurement, image management and report generation.

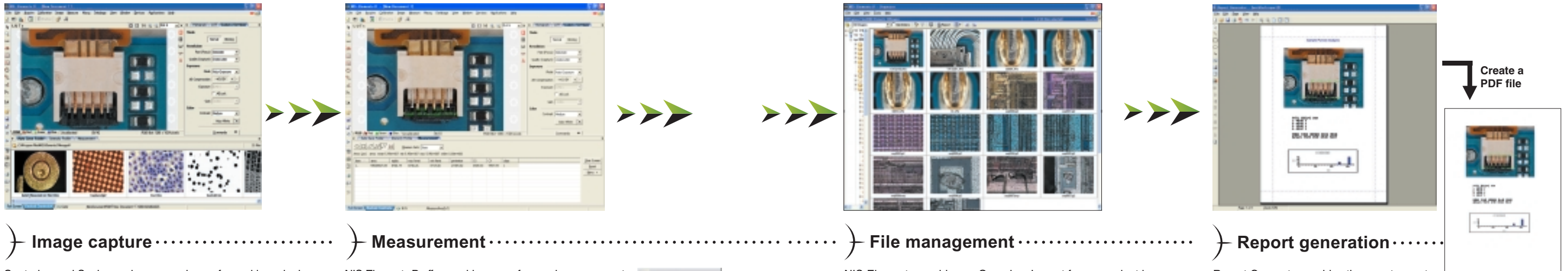
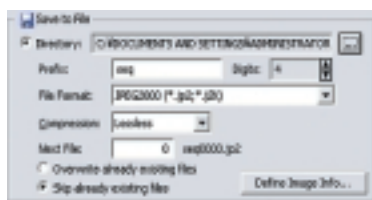


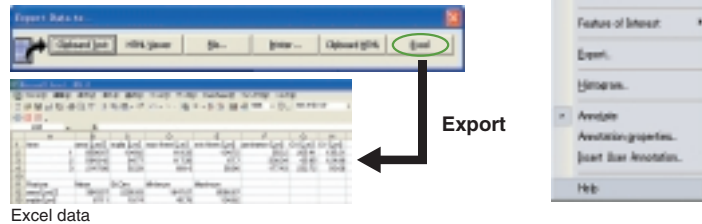
Image capture

Capturing and Saving an image can be performed in a single mouse click. Typical saving parameters such as file name, automatic sequence numbering, storage location, and other image properties can be designated and stored for future image capture. This approach is time efficient as well as an organized method for capturing multiple images.



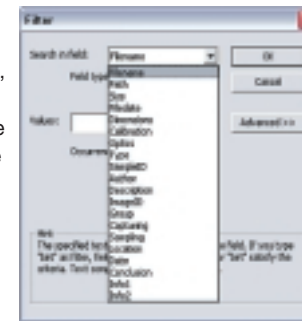
Measurement

NIS-Elements D offers a wide range of manual measurements, including distance between two points, area, auto detect area, radius, angle, counting. Measurement annotations are displayed on the image in a customizable display. Measurement results are also displayed in a data table that can be exported to Excel and other programs.



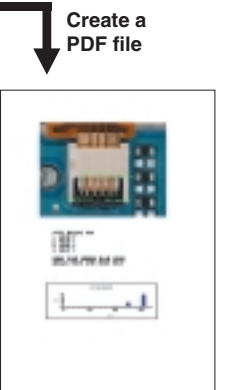
File management

NIS-Elements provides an Organizer Layout for convenient image archiving and file management. Searching, sorting and multiple grouping of images and associated image information can be easily performed by drag and drop. Detail, thumbnail, icon and grid views are available on both the images on the file system as well as images in the optional Database Module.



Report generation

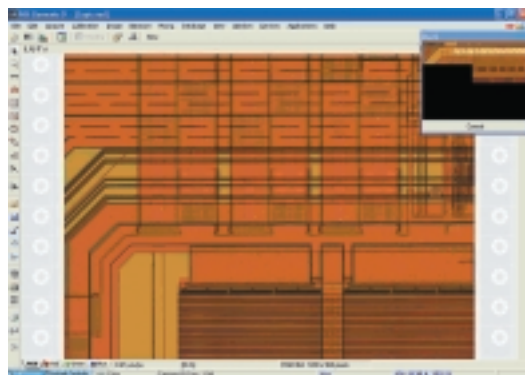
Report Generator enables the user to create customized reports containing images, selected image information from the file or the database, measured data, user text and graphics. Reports can be saved, printed, converted to pdf or e-mailed.



Other Standard Functions

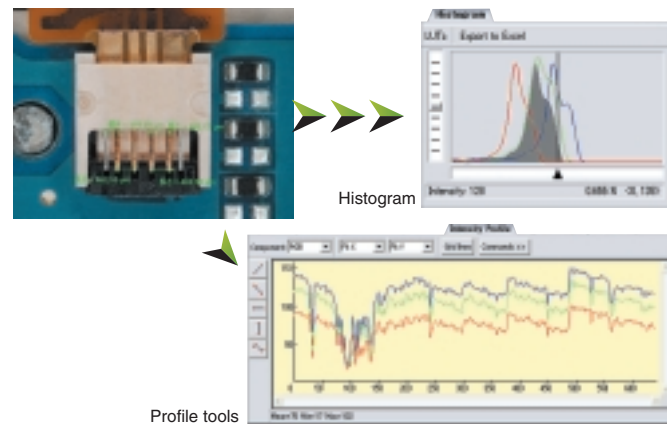
Large Image Stitching

NIS-Elements includes large image stitching capability allowing capture of images larger than the field of view as shown below. Capturing and stitching can be completed with or without an automated stage. Special algorithms ensure maximum accuracy, resulting in ultra high-resolution images.



Display of profiles tools and histogram

Profile Tools: Profile tools are available for plotting intensity, brightness or density into an interactive graph. All output measurement statistics, histograms and profiles can be exported to MS Excel, HTML, or to a file.
Histogram: The histogram is a graph to indicate the brightness of your image to help ensure that the captured images are not over or under exposed.



Time lapse

Time Lapse allows for capturing a sequence of images of events occurring over time, for example crystal formation or some structural change in a material. Interval and Duration are the only parameters that must be entered. Time Lapse images can be saved as AVI movies so they can be replayed on any system.

Macros

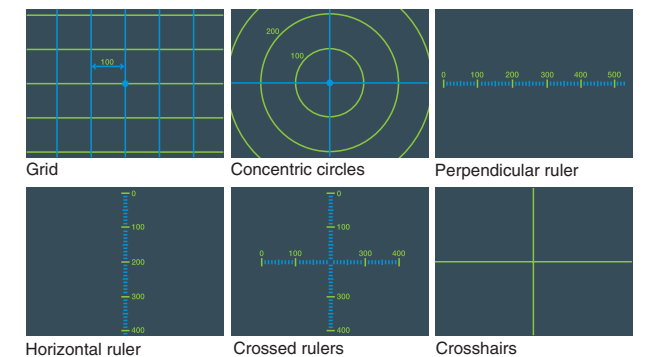
A series of actions can be recorded as a macro and assigned to a toolbar button. This allows for automated execution of a variety of operations at a single touch. Once recorded, macros can be edited and enhanced.

Autofocus

NIS-Elements offer a number of Auto Focus routines to help keep your samples in focus for a single capture or during a time-lapse.

Display of grid overlays

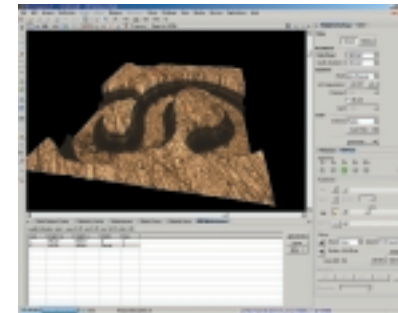
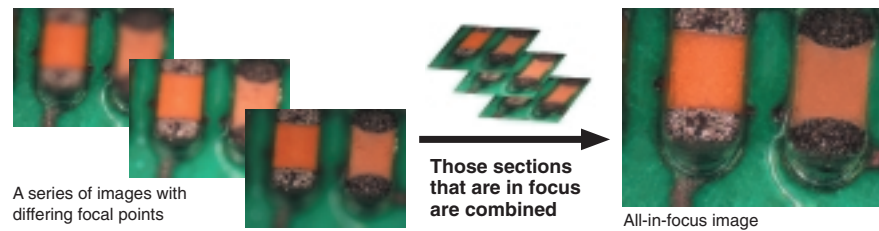
Non-Destructive Overlays that can be displayed on the image include a simple cross hair, grid, concentric circles, horizontal, vertical rulers, etc. Properties such as color, width and density of these overlays can be adjusted.



A comprehensive set of options to easily facilitate complex image capture, analysis and management.

EDF (Extended depth of focus)

EDF allows Images that have been captured in a different Z-axis to be combined to create an all-in-focus image. Once the all in focus image has been created, it can be viewed and rotated as a Virtual 3D image as well as displayed as a stereovision image. Distances along the X,Y and Z axes can be measured in the all in focus image or the 3D image.



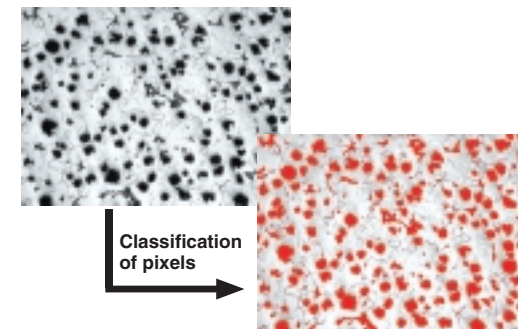
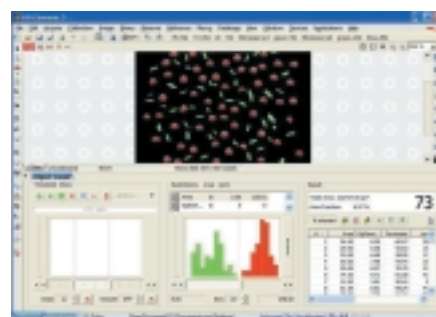
Three dimensional image (LV series only)

Automated Measurement

Using the RGB or HSI color spaces, NIS-Elements can segment the image and create binary images. Using the binary image, Automatic Measurement records features such as length, area, angle and density. There are about 90 different Object and Field that can be measured. The Object Count feature in Automated Measurement provides a consolidated power dialog for thresholding, counting and exporting measurement data.

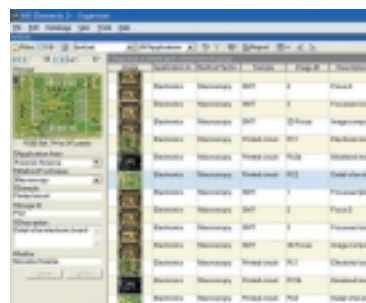
Classifier

Images can be easily classified and displayed by pixel according to user-defined settings based on various characteristics of each pixel, such as brightness, RGB values, HSI values, HS values, etc.



Database option

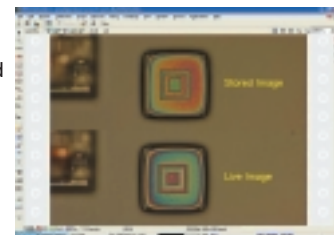
One of the key modules in NIS-Elements is the database capability. Various databases and tables can easily be created to help manage and keep track of your images. A one click option allows saving images directly into the database.



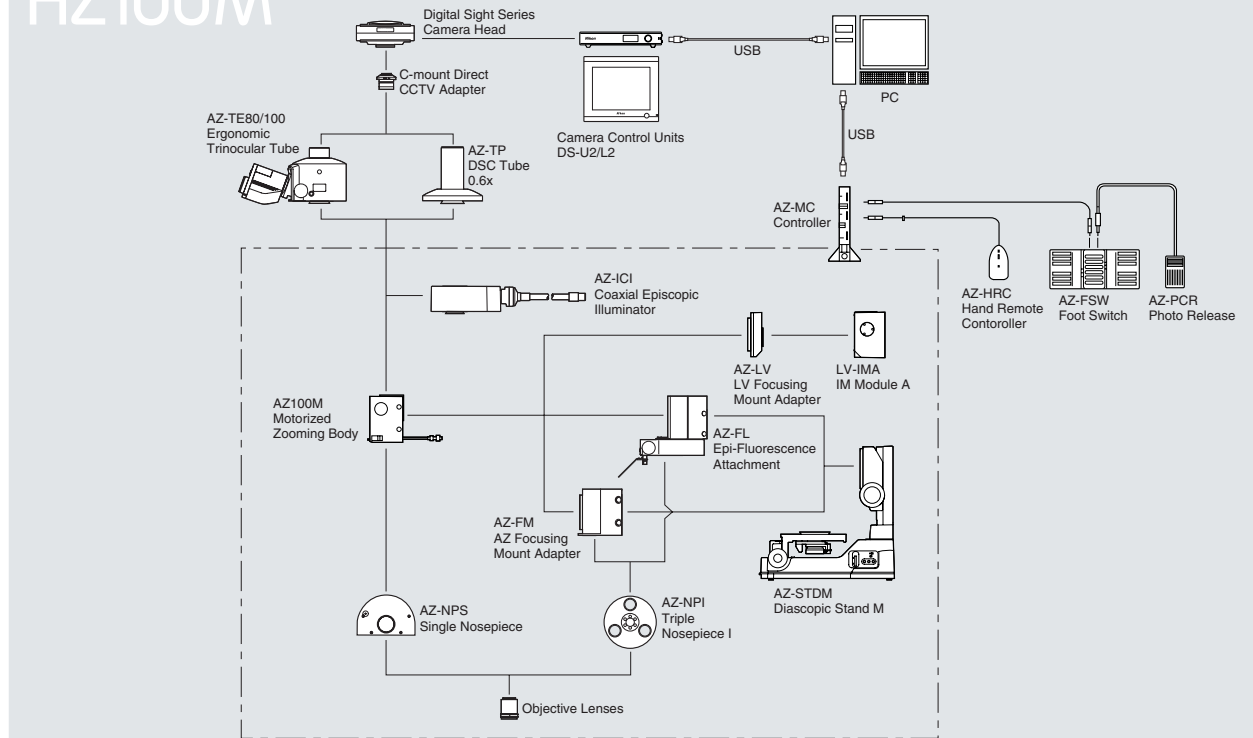
Live Compare

The Live Compare module is ideal for comparing a live image with a stored image for applications such as defect analysis, Go-NoGo assessment and more.

Viewing a stored image and a live image can be displayed in various formats such as side by side, transparent and alternating images.



AZ100M



LV Series

